

Search Notes

Application/Control No.

10/788,660

Examiner

Jezia Riley

Applicant(s)/Patent under
Reexamination

LEE ET AL.

Art Unit

1637

SEARCHED

Class	Subclass	Date	Examiner
536	4.1,26.6	1/21/2008	JR
435	6	1/21/2008	JR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
536	4.1	1/21/2008	JR
536	26.6	1/21/2008	JR
435	6	1/21/2008	JR

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR